

## SEMITOP® 3 Press-Fit

#### SiC MOSFET Module

# Engineering Sample SK45MLET12SCp

**Target Data** 

#### **Features**

- · One screw mounting module
- Fully compatible with other SEMITOP® Press-Fit types
- Improved thermal performance by aluminum oxide substrate
- Three separated Boost legs in very compact solution
- Ultra Low inductance design
- SiC 1200V Planar MOSFET
- SiC 1200V Schottky FWD
- By-pass Rectifier diodes
- Extremely high switching frequency
- UL recognized, file no. E63 532

#### Typical Applications\*

- · Interleaved PFC
- · Solar inverter
- UPS
- Power Supply

#### **Remarks**

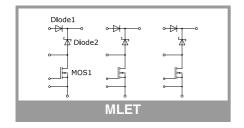
By-pass diode = Diode1 FWD = Diode2

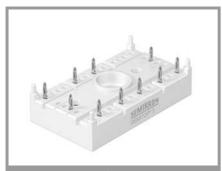
Absolute Maximum Ratings							
Symbol	Conditions		Values	Unit			
MOSFET	1			·			
$V_{DSS}$			1200	V			
I <sub>D</sub>	T <sub>i</sub> = 175 °C	T <sub>s</sub> = 25 °C	39	Α			
	11, = 173 0	T <sub>s</sub> = 70 °C	32	Α			
I <sub>DM</sub>	PW≤10μs, duty	cycle≤1%	160	Α			
I <sub>DRM</sub>			113	Α			
$V_{GS}$			-6 22	V			
Tj			-40 175	°C			
Integrated	Integrated body diode						
I <sub>FM</sub>	PW≤10μs, duty	cycle≤1%	160	Α			
I <sub>FRM</sub>			113	Α			

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
Diode 1	•			·		
$V_{RRM}$	T <sub>j</sub> = 25 °C		1600	V		
I <sub>F</sub>	T 150°C	T <sub>s</sub> = 25 °C	43	Α		
	T <sub>j</sub> = 150 °C	T <sub>s</sub> = 70 °C	32	Α		
I <sub>Fnom</sub>		<u> </u>	35	Α		
I <sub>FSM</sub>	10 ms, sin 180°	°, T <sub>j</sub> = 150 °C	270	Α		
i <sup>2</sup> t	10 ms, sin 180°	°, T <sub>j</sub> = 150 °C	364	A <sup>2</sup> s		
Tj			-40 150	°C		

Absolute Maximum Ratings							
Symbol	Conditions		Values	Unit			
Diode 2							
$V_{RRM}$	T <sub>j</sub> = 25 °C		1200	V			
l <sub>F</sub>	T <sub>i</sub> = 175 °C	T <sub>s</sub> = 25 °C	56	Α			
	- 1 j = 175 C	T <sub>s</sub> = 70 °C	45	Α			
I <sub>Fnom</sub>			50	Α			
I <sub>FRM</sub>			113	Α			
I <sub>FSM</sub>	8.3 ms	T <sub>j</sub> = 25 °C	207	Α			
	sin 180°	T <sub>j</sub> = 150 °C	156	Α			
Tj		•	-40 175	°C			

Absolute Maximum Ratings					
Symbol	Conditions	Values	Unit		
Module					
I <sub>t(RMS)</sub>	T <sub>terminal</sub> = 100 °C, T <sub>S</sub> = 60°C, per pin	40	Α		
T <sub>stg</sub>		-40 125	°C		
V <sub>isol</sub>	AC, sinusoidal, t = 1 min	2500	V		





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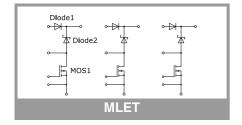
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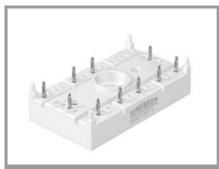
#### **Remarks**

By-pass diode = Diode1 FWD = Diode2

Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
MOSFET 1							
V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ m/s}$	A, T <sub>j</sub> = 25 °C	1200			V	
V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 8.9 \text{ mA}, T_j = 25 \text{ °C}$		1.6		4	V	
I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 12$	00 V, T <sub>j</sub> = 25 °C			1	mA	
I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = 22$	V, T <sub>j</sub> = 25 °C			100	nA	
R <sub>DS(on)</sub>		T <sub>j</sub> = 25 °C		45	56	mΩ	
		T <sub>j</sub> = 150 °C		76	89	mΩ	
C <sub>iss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 80$			4310		pF	
Coss	$V_{GS} = 0 \text{ V}, V_{DS} = 80$	0 V, f = 1 MHz		137		pF	
$C_{rss}$	$V_{GS} = 0 \text{ V}, V_{DS} = 80$	0 V, f = 1 MHz		19		pF	
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			4.7		Ω	
$Q_{G}$	$V_{DS}=600V, V_{GS}=-5V$			215		nC	
t <sub>d(on)</sub>	V <sub>DD</sub> = 600 V	T <sub>j</sub> = 150 °C		12		ns	
$t_{d(off)}$	$V_{GS} = 20/-5 \text{ V}$	T <sub>j</sub> = 150 °C		64		ns	
t <sub>r</sub>	I <sub>D</sub> = 45 A	T <sub>j</sub> = 150 °C		17		ns	
t <sub>f</sub>	$R_G = 0.5 \Omega$	T <sub>j</sub> = 150 °C		16		ns	
E <sub>on</sub>	$di/dt_{off} = 2.2 \text{ kA/}\mu s$ $di/dt_{on} = 3.9 \text{ kA/}\mu s$	T <sub>j</sub> = 150 °C		0.16		mJ	
E <sub>off</sub>	αι/ατοη – 0.0 κ/γμ3	T <sub>j</sub> = 150 °C		0.37		mJ	
R <sub>th(j-s)</sub>	per MOSFET			1.04		K/W	
Integrated	body diode						
$V_F = V_{SD}$	$-I_D = 50 \text{ A}$	T <sub>j</sub> = 25 °C		6.40		V	
	V <sub>GS</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		5.20		V	
$V_{F0} = V_{SD0}$	chiplevel	T <sub>j</sub> = 25 °C		3.90		V	
	Criipievei	T <sub>j</sub> = 150 °C		3.40		V	
$r_F = r_{SD}$	ahinlaval	T <sub>j</sub> = 25 °C		50		mΩ	
	chiplevel	T <sub>j</sub> = 150 °C		36		mΩ	
t <sub>rr</sub>	V <sub>DD</sub> = 600 V			-		ns	
Q <sub>rr</sub>	-I <sub>D</sub> = 45 A			-		μC	
I <sub>rr</sub>	,			-		Α	
E <sub>rr</sub>	$V_{GS} = -5 \text{ V}$			-		mJ	

Characte	Characteristics							
Symbol	Conditions	min.	typ.	max.	Unit			
Diode 1								
$V_{F}$	I <sub>F</sub> = 35 A	T <sub>j</sub> = 25 °C		1.20	1.60	V		
	chiplevel	T <sub>j</sub> = 125 °C		1.19	1.56	V		
$V_{F0}$	chiplevel	T <sub>j</sub> = 25 °C		0.88	0.98	V		
	Criipievei	T <sub>j</sub> = 125 °C		0.73	0.83	V		
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		9.2	18	mΩ		
	- Chilbiesel	T <sub>j</sub> = 125 °C		13	21	mΩ		
I <sub>R</sub>	$T_j = 145 ^{\circ}\text{C},  V_{RRM}$				1.1	mA		
R <sub>th(j-s)</sub>	per Diode			1.7		K/W		





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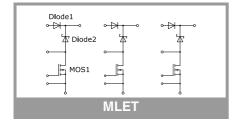
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#### **Remarks**

By-pass diode = Diode1 FWD = Diode2

Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
Diode 2			•				
$V_{F}$	I <sub>F</sub> = 50 A	T <sub>j</sub> = 25 °C		1.40	1.60	V	
	chiplevel	T <sub>j</sub> = 150 °C		1.80	2.10	V	
$V_{F0}$	chiplevel	T <sub>j</sub> = 25 °C		0.95	1.05	V	
	Chipievei	T <sub>j</sub> = 150 °C		0.80	0.90	V	
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		9.0	11	mΩ	
	Criipievei	T <sub>j</sub> = 150 °C		20	24	mΩ	
Cj	$V_R = 800 \text{ V}, f = 1$	V <sub>R</sub> = 800 V, f = 1 MHz, T <sub>j</sub> = 25 °C		0.2		nF	
Q <sub>c</sub>	$V_R = 800 \text{ V, di/dt}_{off} = 500 \text{ A/}\mu\text{s,}$ $T_j = 25 \text{ °C}$			0.17		μС	
R <sub>th(j-s)</sub>	per Diode			1.14		K/W	

Characteristics							
Symbol	Conditions	min.	typ.	max.	Unit		
Module	Module						
Ms	to heatsink	2.25		2.5	Nm		
w	weight		30		g		



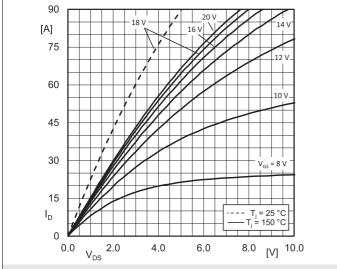


Fig.1: Typ. MOSFET forward output characteristic, incl.  $R_{\text{DD}'+\,\text{SS}'}$ 

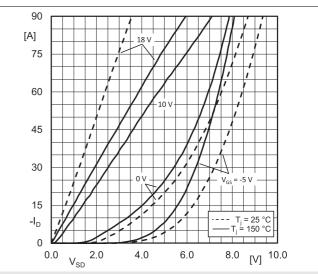


Fig. 2: Typ. MOSFET reverse output characteristic, incl.  $R_{\text{DD'+ SS'}}$ 

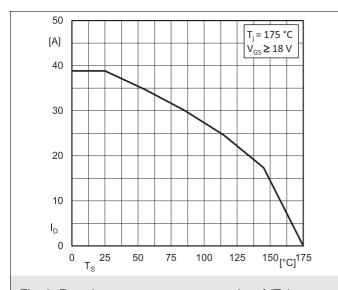


Fig. 3: Rated current vs. temperature  $I_D = f(T_S)$ 

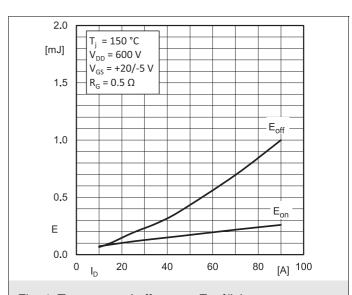


Fig. 4: Typ. turn-on/-off energy  $E = f(I_D)$ 

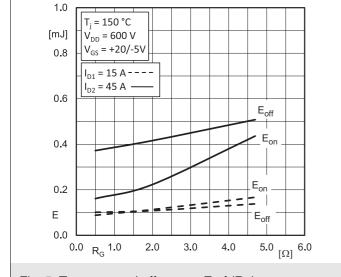


Fig. 5: Typ. turn-on /-off energy E= f (R<sub>G</sub>)

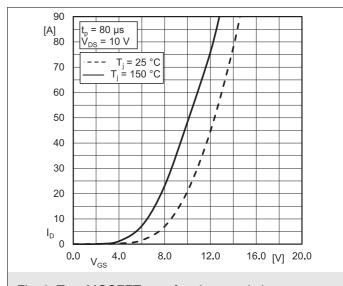
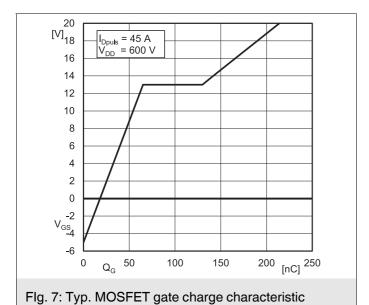
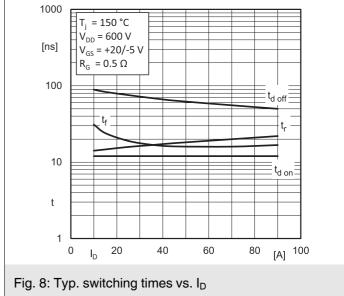
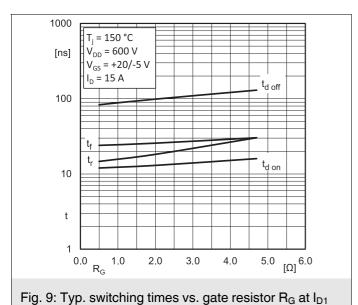
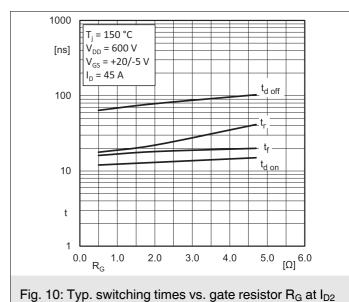


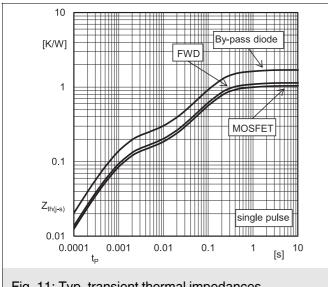
Fig. 6: Typ. MOSFET transfer characteristic











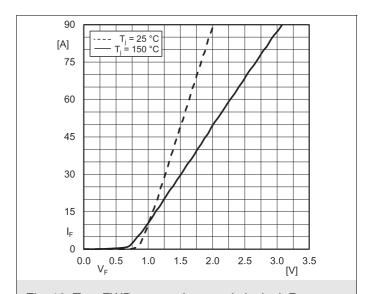


Fig. 11: Typ. transient thermal impedances

Fig. 12: Typ. FWD output characteristic, incl. R<sub>DD'+ SS'</sub>

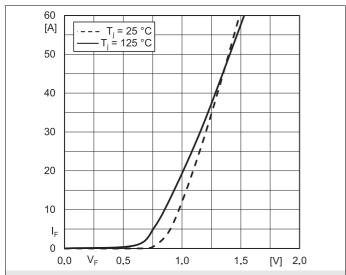
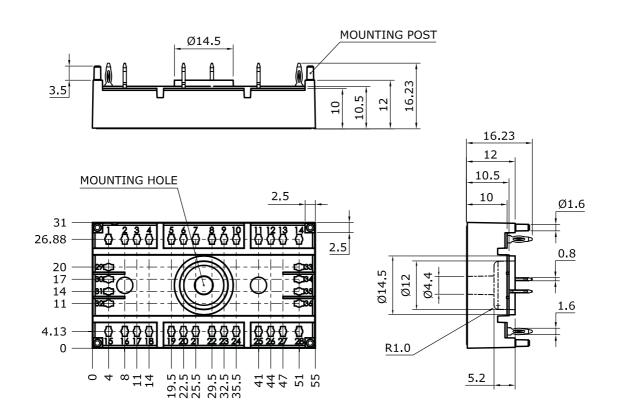


Fig. 13: Typ. by-pass diode output characteristic, inclusive  $R_{DD'+\,SS'}$ 

Dimensions: mm

Tolerance system: ISO 2768-m



Suggested drilled hole diameter for terminal pins in the circuit board:

minimum: 1.575 mmtypical: 1.6 mm

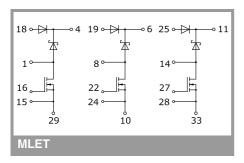
• maximum: 1.625 mm

Suggested hole diameter for the mounting post in the circuit board:

• 2 mm

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#### **SEMITOP 3 Press-Fit**



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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